# **Stellaris® LM4F Microcontrollers Silicon Revisions 6 and 7**

## Silicon Errata



Literature Number: SPMZ856C September 2013–Revised February 2014



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# Stellaris® LM4F Microcontrollers Silicon Revisions 6 and 7

#### 1 Introduction

This document describes known exceptions to the functional specifications for the Stellaris® LM4F microcontrollers that affect revisions up through 6 and 7. Errata that affect only revisions A1, A3 and B0 of the Stellaris® LM4F microcontrollers can be found in the *Stellaris® LM4F RevA1/A3/B0 Errata* for your specific device. Note that some features are not available on all devices in the series, so not all errata may apply to your device. See your device-specific data sheet for more details.

For details on ARM® Cortex<sup>™</sup>-M4F CPU advisories, see the *ARM Core Cortex*<sup>™</sup>-M4 (AT520) and Cortex-M4F (AT521) Errata Notice (literature number: SPMZ637).

## 2 Device Markings

Stellaris® LM4F microcontrollers are marked with an identifying number, as shown in Figure 1. Lines 1 and 2 contain the part number and revision of the device, as well as two internal tracking numbers. Line 3 contains an internal tracking number, including the date code.



Figure 1. Example of Device Part Markings

#### **Part Number**

For example in Figure 1, LM3S9B90 on line 1 followed by IQC80C0 on line 2 indicates device LM3S9B90IQC80 revision C0. The last few characters on line 2 are internal tracking numbers. Note that the second letter in the part number indicates the product status. An M indicates the part is fully qualified and released to production; an X indicates the part is experimental (preproduction) and requires a waiver.

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Device Markings www.ti.com

#### Silicon Revision Code

The revision code printed on the device changed from Stellaris® LM4F to Tiva™ TM4C microcontrollers. All Stellaris® devices were marked with the die revision after the part number. For Tiva™ devices, only preproduction parts include a revision number on the device. For both Stellaris® and Tiva™ devices, the **DID0** register identifies the version of the microcontroller, as shown in Table 1.

Table 1. Stellaris® and Tiva™ Silicon Revision Codes

MAJOR Bit Field Value	MINOR Bit Field Value	Die Revision	Silicon Revision
0x0	0x0	A0	1
0x0	0x1	A1	2
0x0	0x2	A2	3
0x0	0x3	A3	4
0x1	0x0	В0	5
0x1	0x1	B1	6
0x1	0x2	B2	7

### **Date Code**

To determine the date code of the part, look at the first two characters following the dash on the third line of the part markings (highlighted in red in Figure 1). The first number after the dash indicates the last decimal digit of the year. The second character indicates the month. Figure 1 shows a date code of 9B, which indicates November 2009.



## 3 Advisory to Silicon Revision Correlation

## **Advisory to Silicon Revision Matrix**

Advisory	Advisory Title	Silicon Revision(s) Affected					
Number	Advisory Title	<b>A</b> 1	А3	В0	6	7	
	ADC						
ADC#01	Retriggering a Sample Sequencer Before it has Completed the Current Sequence Results in Continuous Sampling	Χ	Х	Х	Х	Х	
ADC#03	Digital Comparator in Last Step of Sequence Does not Trigger or Interrupt	Χ	Х	Х	Х	Х	
ADC#04	Digital Comparator Interrupts do not Trigger or Interrupt as Expected	Χ	Х	Х	Х	Х	
ADC#07	ADC Sample Sequencers Priorities are Different Than Expected	Χ	Х	Х	Х	Х	
ADC#08	ADC Sample Sequencer Only Samples When Using Certain Clock Configurations	X	Х	Х	Х	Х	
ADC#09	First two ADC Samples From the Internal Temperature Sensor Must be Ignored	Χ	Х	Х	Х	Х	
ADC#11	The DITHER bit in the ADC Control (ADCCTL) Register Does not Function	Χ	X	X	X	X	
ADC#13	A Glitch can Occur on pin PE3 When Using any ADC Analog Input Channel to Sample	X	Х	Х	Х	Х	
ADC#14	The First two ADC Samples may be Incorrect	Χ	Х	Х	Х	Х	
ADC#16	Phase Offset does not Delay as Expected if Sample Sequencers are not Triggered at the Same Time	X	Х	Х	Х	Х	
	DMA						
DMA#01	In Three Cases, two Peripherals Cannot Both be Programmed to use μDMA	Χ	Х	Х	Х	Х	
DMA#02	μDMA may be Corrupted if Transferred or Received While Entering or Exiting Deep-Sleep Mode	Χ	Х	Х	Х	Х	
	ELEC						
ELEC#02	$V_{\text{BAT}}$ Supply pin may be Damaged if the pin Voltage Ramps Faster Than 0.7 V/ $\mu s$	Х	Х	Х	Х	Х	
	GPIO						
GPIO#01	JTAG Controller Does not Ignore Transitions on PC0/TCK When it is Configured as a GPIO	Χ	Х	Х	Х	Х	
GPIO#07	GPIO Interrupts Do Not Function Correctly on Ports P and Q	Χ	Х	Х	Х	Х	
GPIO#08	Certain GPIOs Have Limited Pin Configurations	Χ	Х	Х	Х	Х	
	General-Purpose Timers						
GPTM#01	GPTMSYNC Bits Require Manual Clearing	Χ	Х	Х	Х	X	
GPTM#02	The GPTMPP Register Does not Correctly Indicate 32/64-bit Timer Capability	Х	Х	Х	Х	Х	
GPTM#04	Wait-for-Trigger Mode is not Available for PWM Mode	Χ	Х	Х	Х	X	
GPTM#09	General-Purpose Timers do not Synchronize When Configured for RTC or Edge Count Mode	Χ	Х	Х	Х	Х	
GPTM#10	Writes to Some General-Purpose Timer Registers Cause the Counter to Increment and Decrement in Some Cases	X	Х	Х	Х	Х	
GPTM#11	The Prescalar Does not Work Properly When Counting up in Input Edge- Time Mode When the GPTM Timer n Interval Load (GPTMTnILR) Register is Written With 0xFFFF	Х	Х	Х	Х	Х	
GPTM#15	Counter Does not Immediately Clear to 0 When MATCH is Reached In Edge Count Up Mode	Х	Х	Х	Х	Х	
	Hibernation		•	•	•		
HIB#01	Some Hibernation Module Registers may not Have the Correct Value in two Situations	Х	Х	Х	Х	Х	
HIB#02	Reading the HIBRTCC and HIBRTCSS Registers may Provide Incorrect Values	Х	Х	Х	Х	Х	
HIB#03	Device Fails to Wake From Hibernation Within a Certain Time after Hibernation is Requested	Х	Х	Х	Х	Х	
HIB#04	RTC Match Event is Missed if it Occurs in a Certain Window	Χ	Х	Х	Х	Х	



## **Advisory to Silicon Revision Matrix (continued)**

Hilb#14   External Wake Interrupt may be Lost When Returning From Hibernation   X	Silicon Revision(s) Affected						
I2C  I2C#04   PC Glitch Filter Suppression Width may Differ From the Configured Value   X   Memory    MEM#02   The START bit in the EEPROM Support Control and Status (EESUPP)   Register Does not Function   X    MEM#03   EEPROM Data May be Corrupted if an EEPROM Write or Erase is Interrupted   Device may Become Non-functional if an EEPROM Write or Erase is Interrupted    MEM#04   Device may Become Non-functional if Power is Interrupted During an Unlock of the Microcontroller or During Non-volatile Register Commits    MEM#05   Device may Become Non-functional if Power is Interrupted During an Unlock of the Microcontroller or During Non-volatile Register Commits    MEM#08   Writes and Erases to the EEPROM will not Work if the Three EEPROM password Registers are Used for Last EEPROM Block   X    PWM   Under Certain Circumstances, the PWM Load Interrupt is Triggered as   Soon as the PWM is Enabled   Soon as the PWM is Enabled   X    PWM#01   Under Certain Circumstances, the PWM Load Interrupt is Triggered as   X    Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if   X    PWM#01   When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be   X    SSI   SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in   Slave Mode   System Control     X    With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode   System Control     Device May not Wake Correctly From Sleep Mode Under Certain     X    SYSCTL#03   Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon   Entry   Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon   Entry   Entry   Deep-Sleep Mode With the   ETT   ETT	А3	B0	6	7			
MEM#02 The START bit in the EEPROM Support Control and Status (EESUPP) Register Does not Function  MEM#03 The START bit in the EEPROM Support Control and Status (EESUPP) Register Does not Function  MEM#04 The START bit in the EEPROM Support Control and Status (EESUPP) Register Does not Function  MEM#05 Device may Become Non-functional if an EEPROM Write or Erase is Interrupted  MEM#06 Device may Become Non-functional if Power is Interrupted During an Unlock of the Microcontroller or During Non-volatile Register Commits  MEM#08 Writes and Erases to the EEPROM will not Work if the Three EEPROM Password Registers are Used for Last EEPROM Block  PWM  PWM#01 Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  PWM#02 Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  QEI#01 When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSIReceive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  SyscTL#01 Stave Mode  SyscTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#04 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations X  SYSCTL#05 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#10 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X	Х	X	X	X			
MEM#02 The START bit in the EEPROM Support Control and Status (EESUPP) Register Does not Function  MEM#03 EEPROM Data May be Corrupted if an EEPROM Write or Erase is Interrupted  MEM#04 Device may Become Non-functional if an EEPROM Write or Erase is Interrupted  MEM#05 Device may Become Non-functional if Power is Interrupted During an Unlock of the Microcontroller or During Non-volatile Register Commits  MEM#08 Writes and Erases to the EEPROM will not Work if the Three EEPROM Password Registers are Used for Last EEPROM Block  PWM  PWM#01 Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  PWM#02 Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  QEI#01 When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  SYSCTL#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  SYSCTL#04 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations X  SYSCTL#05 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations X  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations X  SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  SYSCTL#16 On-Chip LDO may not Start Properly During Power Up							
MEM#02 The START bit in the EEPROM Support Control and Status (EESUPP) Register Does not Function  MEM#03 EEPROM Data May be Corrupted if an EEPROM Write or Erase is Interrupted  Device may Become Non-functional if an EEPROM Write or Erase is Interrupted  MEM#04 Device may Become Non-functional if Power is Interrupted During an Unlock of the Microcontroller or During Non-volatile Register Commits  MEM#05 Writes and Erases to the EEPROM will not Work if the Three EEPROM Password Registers are Used for Last EEPROM Block  PWM  PWM#01 Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  PWM#02 Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  QEI#01 When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  SYSCTL#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  SYSCTL#04 Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations X  SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LPIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode SYSCTL#16 On-Chip LDO may not Start Properly During Power Up	Х	X	X	X			
Register Does not Function  MEM#03  EEPROM Data May be Corrupted if an EEPROM Write or Erase is Interrupted  Device may Become Non-functional if an EEPROM Write or Erase is Interrupted  MEM#05  Device may Become Non-functional if Power is Interrupted During an Unlock of the Microcontroller or During Non-volatile Register Commits  Writes and Erases to the EEPROM will not Work if the Three EEPROM Password Registers are Used for Last EEPROM Block  PWM  PWM#01  Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  QEI  When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  SYSCTL#01  With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03  The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  Device May not Wake Correctly From Sleep Mode Under Certain  X SYSCTL#06  Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  X SYSCTL#07  Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#10  Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14  Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X SYSCTL#16  On-Chip LDO may not Start Properly During Power Up							
Interrupted  MEM#04  Device may Become Non-functional if an EEPROM Write or Erase is Interrupted  Device may Become Non-functional if Power is Interrupted During an Unlock of the Microcontroller or During Non-volatile Register Commits  MEM#08  Writes and Erases to the EEPROM will not Work if the Three EEPROM Password Registers are Used for Last EEPROM Block  PWM  PWM#01  Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  PWM#02  Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  Sysem Control  Sysem Control  With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SysCTL#01  The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  SySCTL#04  Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SySCTL#06  Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  X  SYSCTL#07  Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11  Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14  Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X  SYSCTL#16  On-Chip LDO may not Start Properly During Power Up	Х	Х	Х	Х			
MEM#05  Device may Become Non-functional if Power is Interrupted During an Unlock of the Microcontroller or During Non-volatile Register Commits  Writes and Erases to the EEPROM will not Work if the Three EEPROM Password Registers are Used for Last EEPROM Block  PWM  PWM#01  Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  PWM#02  Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  QEI  QEI#01  When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  SyscTL#01  With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03  The MOSC Verification Circuit Does not Detect a Loss of Clock After the Circumstances  SYSCTL#04  Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#01  Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11  Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14  Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X SYSCTL#16  On-Chip LDO may not Start Properly During Power Up	Х	Х	X				
MEM#08 Writes and Erases to the EEPROM will not Work if the Three EEPROM Password Registers are Used for Last EEPROM Block  PWM  PWM#01 Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  PWM#02 Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  QEI#01 When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  SYSCTL#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  SYSCTL#04 Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations X  SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#16 On-Chip LDO may not Start Properly During Power Up  X		Х	Х				
Password Registers are Used for Last EEPROM Block  PWM  PWM#01 Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  PWM#02 Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  QEI#01 When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  Sysctl#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations X  SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X SYSCTL#16 On-Chip LDO may not Start Properly During Power Up		Х	Х	х			
PWM#01 Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  PWM#02 Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  QEI#01 When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  Sysch Control  With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#01 Device May not Wake Correctly From Sleep Mode Under Certain Clock has been Successfully Operating  SYSCTL#04 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  X SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X SYSCTL#16 On-Chip LDO may not Start Properly During Power Up  X	Х	Х	Х	х			
Soon as the PWM is Enabled  PWM#02 Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  QEI  QEI#01 When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  SyscTL#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  SYSCTL#04 Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  X SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X SYSCTL#16 On-Chip LDO may not Start Properly During Power Up  X							
QEI  When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  System Control  SYSCTL#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  SYSCTL#04 Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  X SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X SYSCTL#16 On-Chip LDO may not Start Properly During Power Up	Х	Х	Х	Х			
When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in the QEI Module Causes the Direction for the First Count to be Misread  SSI  SSI SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  System Control  SYSCTL#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  SYSCTL#04 Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X SYSCTL#16 On-Chip LDO may not Start Properly During Power Up	Х	Х	Х	Х			
SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  System Control  With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#04  Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  SYSCTL#07  Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11  Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14  Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X  SYSCTL#16  On-Chip LDO may not Start Properly During Power Up  X							
SSI#06 SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  System Control  SYSCTL#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  SYSCTL#04 Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X SYSCTL#15 On-Chip LDO may not Start Properly During Power Up	Х	х	Х	х			
System Control  System Control  With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  Sysctl#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  Sysctl#04 Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  Sysctl#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  Sysctl#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  Sysctl#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  Sysctl#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X Sysctl#16 On-Chip LDO may not Start Properly During Power Up	1						
SYSCTL#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode  SYSCTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  SYSCTL#04 Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X SYSCTL#16 On-Chip LDO may not Start Properly During Power Up	Х	Х	Х	Х			
SYSCTL#01 Sleep Mode  The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has been Successfully Operating  Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X  SYSCTL#15 On-Chip LDO may not Start Properly During Power Up				-1			
Clock has been Successfully Operating  SYSCTL#04  Device May not Wake Correctly From Sleep Mode Under Certain Circumstances  SYSCTL#06  Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  X  SYSCTL#07  Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11  Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14  Power Consumption is Higher When MOSC is Used in Single-Ended Mode  X  SYSCTL#16  On-Chip LDO may not Start Properly During Power Up	Х	Х	Х	х			
SYSCTL#04 Circumstances  SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations  SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode  SYSCTL#15 On-Chip LDO may not Start Properly During Power Up  X	Х	Х	Х	х			
SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry  SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode X  SYSCTL#16 On-Chip LDO may not Start Properly During Power Up	Х	х	Х	Х			
SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode X  SYSCTL#16 On-Chip LDO may not Start Properly During Power Up  X	Х	X	Х	Х			
SYSCTL#11 LFIOSC as the Clock Source  SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode X  SYSCTL#16 On-Chip LDO may not Start Properly During Power Up  X	Х	Х	Х	Х			
SYSCTL#16 On-Chip LDO may not Start Properly During Power Up X	Х	Х	Х	Х			
	Χ	Х	X	X			
SYSCTL#17 DSDIVORIDE Value of 0x1 Does Not Divide Deep-Sleep Clock by 2 X	Х	Х	Х	Х			
	Х	Х	Х	Х			
UART							
UART#01 When UART SIR Mode is Enabled, µDMA Burst Transfer Does not Occur X	Х	Х	Х	Х			
USB	1	1		1			
USB#01 USB Host Controller may not be Used to Communicate With a Low-Speed Device When Connected Through a hub	Х	Х	Х	Х			
USB#02 USB Controller Sends EOP at end of Device Remote Wake-Up X	Х	Х	Х	Х			



## **Advisory to Silicon Revision Matrix (continued)**

Advisory Number	Advisory Title	Silicon Revision(s) Affected						
		<b>A</b> 1	А3	В0	6	7		
	Watchdog Timers							
WDT#01	Watchdog Timer 1 Module Cannot be Used Without Enabling Other Peripherals First	Х	Х	Х	Х	Х		
WDT#02	Watchdog Clear Mechanism Described in the Data Sheet Does not Work for the Watchdog Timer 1 Module	Х	Х	Х	Х	Х		
WDT#03	Watchdog Timer 1 Module Asserts Reset Signal Even if not Programmed to Reset	Х	Х	Х	Х	Х		
WDT#05	WDTLOAD Yields an Incorrect Value When Read Back	Χ	Х	Х	Χ	Х		
WDT#06	WDTMIS Register Does not Indicate an NMI Interrupt From WDT0	Χ	Х	Х	Χ	Х		
WDT#07	The Watchdog Load (WDTLOAD) Register Cannot be Changed When Using a Debugger While the STALL bit is set	Х	Х	Х	Х	Х		
WDT#08	Reading the WDTVALUE Register may Return Incorrect Values When Using Watchdog Timer 1	Х	Х	Х	Х	Х		



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ADC#01 Retriggering a Sample Sequencer Before it has Completed the Current Sequence

Results in Continuous Sampling

Revision(s) Affected: A1, A3, B0, 6, and 7.

Re-triggering a sample sequencer before it has completed its programmed conversion **Description:** 

sequence causes the sample sequencer to continuously sample. If interrupts have been enabled, interrupts are generated at the appropriate place in the sample sequence. This

problem only occurs when the new trigger is the same type as the current trigger.

Workaround(s): Ensure that a sample sequence has completed before triggering a new sequence using

the same type of trigger.



ADC#03 Digital Comparator in Last Step of Sequence Does not Trigger or Interrupt

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** If a digital comparator that is expected to trigger or interrupt is configured for the last

step of a sample sequence with sequence trigger TRIGGER\_PROCESSOR,

TRIGGER\_COMP, TRIGGER\_EXTERNAL, TRIGGER\_TIMER, or TRIGGER\_PWM, the trigger or interrupt does not occur. These sequence trigger parameters should not be used when using a sample sequencer configured with only one step and a digital comparator that is expected to trigger or interrupt. Note that Sample Sequencer 3 can

only be configured for a total of one step.

Workaround(s): If an extra sequence step is available in a sample sequencer, a dummy sequence step

and a dummy digital comparator can be configured as the last step in the sample

sequencer.



ADC#04 Digital Comparator Interrupts do not Trigger or Interrupt as Expected

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The digital comparator configured for the ADC sample sequence step (n+1) is triggered

if the voltage on the AINx input specified for step (n) meets the conditions that trigger the digital comparator for step (n+1). In this case, the conversion results are sent to the

digital comparator specified by step (n+1).

Workaround(s): Adjust user code or hardware to account for the fact that the voltage seen at the AINx

input specified for sequence step (n) will be handled by sequence step (n+1)'s digital

comparator using sequence step (n+1)'s configurations.



### ADC#07 ADC Sample Sequencers Priorities are Different Than Expected

Revision(s) Affected: A1, A3, B0, 6, and 7.

Description: If sample sequencer 2 (SS2) and sample sequencer 3 (SS3) have been triggered, and

sample sequencer 0 (SS0) and sample sequencer 1 (SS1) have not been triggered or have already been triggered, the priority control logic compares the priorities of SS1 and SS2 rather than SS2 and SS3. For example, if SS1's priority is the highest (such as 0) and SS3's priority is higher than SS2's priority (such as SS3 = 1, SS2 = 2), SS2 is incorrectly selected to initiate the sampling conversion after SS1. If SS1's priority is the lowest (such as 3) and SS3's priority is lower than SS2's (such as SS3 = 2, SS2 = 1), SS3 is incorrectly selected as the next sample sequencer, then SS2, then SS1.

Workaround(s): If only three of the four ADC sample sequencers are needed, SS0 and SS1 can be used

with either SS2 or SS3. This ensures that the execution order is as expected. If all four ADC sample sequencers are needed, the highest priority conversions should be programmed into SS0 and SS1. The sequences programmed into SS2 and SS3 occur,

but not necessarily in the programmed priority order.



ADC#08 ADC Sample Sequencer Only Samples When Using Certain Clock Configurations

**Revision(s) Affected:** A1, A3, B0, 6, and 7.

**Description:** The ADC sample sequencer does not sample if using either the MOSC or the PIOSC as

both the system clock source and the ADC clock source.

**Workaround(s):** There are three possible workarounds:

Enable the PLL and use it as the system clock source.

Configure the MOSC as the system clock source and the PIOSC as the ADC clock

source.

• Enable the PLL, configure the PIOSC as the ADC clock source and as the system clock source, then subsequently disable the PLL using HWREG(0x400fe060) != 0x00000200.



ADC#09 First two ADC Samples From the Internal Temperature Sensor Must be Ignored

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The analog source resistance (R<sub>s</sub>) to the ADC from the internal temperature sensor

exceeds the specified amount of 500Ω. This causes a settling time requirement that is

longer than the sampling interval to the converter.

Workaround(s): Three consecutive samples from the same channel must be taken to accurately sample

the internal temperature sensor using the ADC. The first two consecutive samples should be discarded and the third sample can be kept. These consecutive samples

cannot be interrupted by sampling another channel.



ADC#11 The DITHER bit in the ADC Control (ADCCTL) Register Does not Function

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The DITHER bit in the ADC Control (ADCCTL) register does not function.



ADC#13 A Glitch can Occur on pin PE3 When Using any ADC Analog Input Channel to

Sample

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description** A glitch may occur on PE3 when using any ADC analog input channel (AINx) to sample.

This glitch can occur when PE3 is configured as a GPIO input or as a GPIO open drain and happens at the end of the ADC conversion. These glitches will not affect analog measurements on PE3 when configured as AINO as long as the specified source

resistance is met.

Workaround(s) A  $1k\Omega$  external pull-up or pull-down on PE3 will help to minimize the magnitude of the

glitch to 200 mV or less.



ADC#14 The First two ADC Samples may be Incorrect

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description** The first two ADC samples taken after the ADC clock is enabled in the xCGCADC

register may be incorrect.

Workaround(s) Reset the ADC peripheral using the SRADC register after the ADC peripheral clock is

enabled and before initializing the ADC and enabling the sample sequencer.



ADC#16 Phase Offset does not Delay as Expected if Sample Sequencers are not Triggered

at the Same Time

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The phase difference set in the ADC Sample Phase Control (ADCSPC) register does not

reference the same starting point in time if the sequencers are configured for a phase

offset and are not triggered at the same time.

Workaround(s): Use the same trigger to ensure that the sample sequencers will trigger at the same time.

If using processor trigger and both ADC modules with phase offset, use the GSYNC and SYNCWAIT bits in the ADC Processor Sample Sequence Initiate (ADCPSSI) register to

ensure that the trigger occurs simultaneously. The phase offsets will not align if

triggering using trigger always mode.



DMA#01 In Three Cases, two Peripherals Cannot Both be Programmed to use μDMA

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** For the following pairs of peripherals, both peripherals cannot both be configured to use

μDMA:

SSI0 and SSI1

UART2 and USB0EP1UART0 and UART2

Workaround(s): Configure peripherals such that the combinations of peripherals listed above are not both

using  $\mu DMA$ .



DMA#02 μDMA Data may be Corrupted if Transferred or Received While Entering or Exiting

Deep-Sleep Mode

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** Transferred or received data using the μDMA from either the UART or the SSI

peripherals may get corrupted when entering Deep-Sleep mode from Run mode or exiting Deep-Sleep mode to Run mode if the Run mode clock configuration is not the

same as the Deep-Sleep mode clock configuration.

Workaround(s): Program the Run mode clock configuration to match the Deep-Sleep mode clock

configuration right before entering Deep-Sleep mode.



ELEC#02  $V_{BAT}$  Supply pin may be Damaged if the pin Voltage Ramps Faster Than 0.7 V/µs

A1, A3, B0, 6, and 7. Revision(s) Affected:

The  $V_{BAT}$  supply pin may be damaged if the pin voltage ramps faster than 0.7 V/ $\mu$ s. Fast  $V_{BAT}$  ramps are a concern when a battery is being connected or the  $V_{BAT}$  supply is hard Description

switched.

An RC circuit as shown should be added to the  $V_{BAT}$  pin to prevent the damage. The  $R_1$  and  $C_1$  should be placed close to the microcontroller for best protection. In systems that Workaround(s)

do not require Hibernate when the VDD supply is off, the  $V_{BAT}$  pin should be tied to the VDD supply, which typically ramps at a rate slower than 0.7 V/µs. The R1 and C1

components are not required for a  $V_{BAT}$  supply ramp less than 0.7 V/ $\mu$ s.

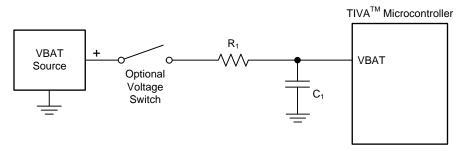


Figure 2. RC Circuit



GPIO#01 JTAG Controller Does not Ignore Transitions on PC0/TCK When it is Configured

as a GPIO

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** When PC0/TCK is configured as a GPIO, toggling on the pin may cause the device to

execute unexpected JTAG instructions.

Workaround(s): Only use PC0/TCK as a JTAG pin. Do not use it as a GPIO. Ensure that this pin is

connected to a pull-up to VDD.



#### GPIO#07

## GPIO Interrupts Do Not Function Correctly on Ports P and Q

Revision(s) Affected:

A1, A3, B0, 6, and 7.

**Description:** 

Ports P and Q are designed to provide either a single interrupt where interrupts for all pins on the port are OR'ed together or multiple interrupts where each port pin has an individual interrupt. This function is controlled by the SUM bit in the GPIO Select Interrupt (GPIOSI) register. When SUM is 0 and the interrupt occurs on a pin other than pin 0, an interrupt on pin 0 is triggered in addition to the interrupt on the other pin(s). The interrupt on the pin(s) other than pin 0 is unexpected.

#### Workaround(s):

To configure GPIO ports P or Q for summary interrupt mode, the following additional steps are required:

- For a port pin to be included in the summary interrupt on P0 or Q0 the corresponding bit must be set in the GPIOIM register
- For each port pin other than P0 or Q0 that is enabled in GPIOIM, the corresponding bit(s) must be set in the Interrupt Clear Disable (DISn) register to avoid generating undesired interrupts

For each port pin that is configured as edge-detect in summary interrupt mode, the following additional steps are required in the P0 or Q0 interrupt service routine:

- Write a 1 to the corresponding bit(s) in GPIOICR to clear the interrupt in the GPIO module
- Write a 1 to the corresponding bit(s) in the UNPENDn register to clear the pending interrupt in the NVIC

For each port pin that is configured as level-detect in summary interrupt mode, the following additional steps are required in the P0 or Q0 interrupt service routine:

 Write a 1 to the corresponding bit(s) in the UNPENDn register to clear the pending interrupt in the NVIC

To configure ports P and Q for per-pin interrupt mode, no additional steps are required.



## GPIO#08 Certain GPIOs Have Limited Pin Configurations

**Revision(s) Affected:** A1, A3, B0, 6, and 7.

**Description:** The following pins (which are dependent on pin package) are fixed at a 4 mA pad drive

and are not configurable for open drain:

PL6 and PL7 (157-BGA, 144-LQFP)

PD4 and PD5 (64-LQFP)

PJ0 and PJ1 (100-LQFP)

Writes to the GPIODR2R, GPIODR8R, or GPIOODR registers for these two pins have

no effect.



GPTM#01 GPTMSYNC Bits Require Manual Clearing

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The GPTM Synchronize (GPTMSYNC) register allows software to synchronize a number

of timers. The bits in this register should be self-clearing after setting bits to synchronize

selected timers, but they are not.

Workaround(s): When bits in the GPTMSYNC register are set, software must clear the bits prior to

setting them for a subsequent update. When using TivaWare™ APIs, instead of just calling the *TimerSynchronize()* function once, software should call the function a second

time with 0 as a parameter, as shown below:

TimerSynchronize(TIMER0\_BASE, TIMER\_0A\_SYNC | TIMER\_1A\_SYNC);

TimerSynchronize(TIMER0\_BASE, 0);



GPTM#02 The GPTMPP Register Does not Correctly Indicate 32/64-bit Timer Capability

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The GPTM Peripheral Properties (GPTMPP) register reads as 0x0 on the 32/64-bit wide

timers, which indicates that the timer is a 16/32-bit timer. It should read as 0x1 on these

timers, indicating a 32/64-bit wide timer.

Workaround(s): In situations where code is required to dynamically determine the capabilities of a

specific timer, create a look-up table based on the CLASS field of the Device

Identification 0 (DID0) register.



GPTM#04 Wait-for-Trigger Mode is not Available for PWM Mode

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** Daisy chaining functionality of the general-purpose timers is only valid for One-shot and

Periodic modes. If the TnWOT bit of the GPTM Timer n Mode (GPTMTnMR) register is set, and the nth timer is configured for PWM mode, the nth timer will not wait for the (n-1)th timer to trigger it and will begin counting immediately when enabled. If, instead, the nth timer is configured for One-shot or Periodic mode and the (n-1)th timer is configured for PWM mode, the nth timer would never begin counting as it will never receive a trigger

from the (n-1)th timer in the daisy chain.





GPTM#09 General-Purpose Timers do not Synchronize When Configured for RTC or Edge

Count Mode

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** When attempting to synchronize the General-Purpose Timers using the GPTM

Synchronize (GPTMSYNC) register, they do not synchronize if any of the timers are

configured for RTC or Edge Count mode.



GPTM#10 Writes to Some General-Purpose Timer Registers Cause the Counter to Increment

and Decrement in Some Cases

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** Writes to the following registers when the timer is enabled cause the counter to

increment in up count mode and decrement in down count mode when incrementing or

decrementing the counter inside the General-Purpose timers:

GPTM Timer n Match (GPTMTnMATCHR)

• GPTM Timer n Prescale (GPTMTnPR)

Situations in which the counter is incremented or decremented include:

RTC Mode

· Input edge count mode





GPTM#11 The Prescalar Does not Work Properly When Counting up in Input Edge-Time

Mode When the GPTM Timer n Interval Load (GPTMTnlLR) Register is Written With

0xFFFF

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** If the GPTM is configured in Input Edge-Time count-up mode with the GPTM Timer n

Interval Load (GPTMTnILR) register equal to 0xFFFF, the prescaler does not work

properly.

Workaround(s): Do not load 0xFFFF into the GPTMTnlLR register when counting up in Input Edge-Time

mode.



GPTM#15 Counter Does not Immediately Reset to 0 When MATCH is Reached In Edge Count

**Up Mode** 

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description** When configured for input edge count mode and count up mode, after counting to the

match value, the counter uses one additional edge to reset the timer to 0. As a result, after the first match event, all subsequent match events occur after the programmed

number of edge events plus one.

Workaround(s) In software, account for one additional edge in the programmed edge count after the first

match interrupt is received.



**HIB#01** 

Some Hibernation Module Registers may not Have the Correct Value in two Situations

Revision(s) Affected:

A1, A3, B0, 6, and 7.

**Description:** 

Some Hibernation module registers may not have the correct value in two different situations:

- 1. After enabling the hibernation 32-kHz oscillator by setting the CLK32EN bit in the Hibernation Control (HIBCTL) register.
- 2. When the CLK32EN bit is set, both the RTCEN and PINWEN bits in the HIBCTL register are clear, and any kind of reset occurs.

The following Hibernation module registers are affected:

- HIBRTCLD
- HIBRTCM0
- HIBRTCSS
- HIBRTCT
- HIBIM

Note that the register values may or may not be correct, but software cannot assume that these registers have any specific values following the occurrence of the situations described above.

Workaround(s):

Ensure that every bit in these registers is correctly initialized in application software following the occurrence of the situations described above.



## HIB#02 Reading the HIBRTCC and HIBRTCSS Registers may Provide Incorrect Values

**Revision(s) Affected:** A1, A3, B0, 6, and 7.

Description: Reads from the Hibernation RTC Counter (HIBRTCC) and Hibernation RTC Sub

Seconds (HIBRTCSS) registers may not be correct.

Workaround(s): Use the following code sequence to read from the HIBRTCS and HIBRTCSS registers:

```
//
// Disable Interrupts
//
IntMasterDisable();
//
// A) For HIB_RTCC or HIB_RTCSS individual register reads
//
do
{
    ulrrc = HWREG(HIB_RTCC);
}
    while (ulRTC != HWREG(HIB_RTCC));
//
// B) For synchronized reads of both the HIB_RTCC and HIB_RTCSS
//
do {
    ulrtc = HWREG(HIB_RTCC);
    ulrTCSS = HWREG(HIB_RTCSS);
    ulrTCSS2 = HWREG(HIB_RTCSS);
    ulrTC1 = HWREG(HIB_RTCC);
   while ((ulrtc != ulrtc1) || (ulrtcss != ulrtcss2));
//
// Re-enable interrupts
//
IntMasterEnable();
```



**HIB#03** 

Device Fails to Wake From Hibernation Within a Certain Time after Hibernation is Requested

Revision(s) Affected:

A1, A3, B0, 6, and 7.

**Description:** 

If a wake event occurs during a small window after the device enters Hibernate mode, the device cannot wake from hibernation. The window in which this issue occurs extends from 31  $\mu$ s before the  $\overline{\text{HIB}}$  signal is asserted until  $V_{DD}$  drops below the BOR threshold, if BOR is enabled, or the POR falling edge threshold. Note that this erratum does not apply when using the VDD3ON mode because  $V_{DD}$  does not drop in this mode.

Workaround(s):

Add a TivaWare™ SysCtlReset() function after the hibernation request in the following manner:

```
HibernateRequest();
//
// Wait till the isolation has been applied
//
while ((HWREG(HIB_CTL) & HIB_CTL_CLK32EN) == HIB_CTL_CLK32EN)
{
}
SysCtlReset();
```

In addition, add the following code to the reset handler

```
//
// Halt code execution if in Hibernate as supplies decay
//
while( HWREG(HIBCTL) == 0x80000000)
{
}
```



HIB#04 RTC Match Event is Missed if it Occurs in a Certain Window

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** An RTC match event is missed if the match occurs within three 32.768-kHz clocks (92

μs) after setting the HIBREQ bit in the Hibernation Control (HIBCTL) register.

Workaround(s): Compare the RTC counter value before going into hibernation with the RTC match value

and if the match is within three counts of the RTC sub seconds counter, hold off entering

into hibernation until the match has occurred.



### HIB#14 External Wake Interrupt may be Lost When Returning From Hibernation

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description** A WAKE pin interrupt, EXTW, may be lost while returning from non-VDD3ON

hibernation. The sequence begins as  $\overline{\text{WAKE}}$  is asserted to trigger the exit of hibernation. The  $\overline{\text{HIB}}$  is de-asserted to enable the VDD supply. If the VDD supply drops below the Power-On Reset threshold after being above the threshold for 1-2 hibernate clock cycles (typically 30-60  $\mu$ s), the device continues to wake, but the EXTW interrupt will not occur.

**Workaround(s)** For systems which require all EXTW events to be accounted for, one of two methods may be used to ensure an EXTW interrupt is not missed.

 Do not generate a wake event until the VDD supply has dropped below the minimum Power-On Reset threshold.

• Ensure the VDD supply begins to rise less than 2 hibernate clock cycles (typically 60 µs) from when the HIB signal has been de-asserted.

Once the supply is above the Power-On Reset threshold for 1-2 hibernate clock cycles (typically 30-60  $\mu$ s), the supply should not drop below the Power-On Reset threshold to retain the EXTW interrupt.



12C#04 fC Glitch Filter Suppression Width may Differ From the Configured Value

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The I<sup>2</sup>C glitch filter pulse width is configured using the GFPW bit field in the I<sup>2</sup>C Master

Configuration 2 (I2CMCR2) register. Due to a logic error in the initialization of the glitch filter, the actual pulse width may differ from what is expected. This issue rarely occurs, but is not predictable in software. The following table outlines the different pulse widths

that may occur with respect to the value written to the GFPW bit field.

## Expected vs. Actual I<sup>2</sup>C Glitch Suppression Pulse Width

GFPW[6:4]	Glitch Suppression Pulse Width	
	Expected Value [system clocks]	Actual Value [system clocks]
0x0	Bypass	Bypass
0x1	1 clock	0-1 clock
0x2	2 clocks	0-3 clocks
0x3	3 clocks	0-3 clocks
0x4	4 clocks	0-7 clocks
0x5	8 clocks	0-15 clocks
0x6	16 clocks	0-31 clocks
0x7	31 clocks	0-31 clocks





MEM#02 The START bit in the EEPROM Support Control and Status (EESUPP) Register

Does not Function

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** Setting the START bit should begin error recovery if the PRETRY or ERETRY bit in the

EESUPP register is set. However, setting this bit does not perform any function.

Workaround(s): Execute the EEPROMInit() function and then manually retry the failed operation.



### MEM#03 EEPROM Data May be Corrupted if an EEPROM Write is Interrupted

**Revision(s) Affected:** A1, A3, B0, and 6.

**Description:** Corrupted EEPROM data can occur if an EEPROM write is interrupted with any of the

following power events:

Power failure

External reset (RST)

Brown-out (BOR) event

When the WORKING bit of the EEDONE register is set, an EEPROM program or erase operation is occuring. The corrupted EEPROM data that can result from this sequence is not limited to the current word being written. If these events do not apply to your system, then normal EEPROM operation is expected. If a failure occurs, there will not be any indication of the failed erase or corrupted data (for example in the PRETRY and the ERETRY bits in the EEPROM Support Control and Status (EESUPP) register.

Workaround(s):

Configure the external reset ( $\overline{RST}$ ) and the watchdog reset to issue a system reset ( $\overline{EXTRES} = 0x2$  and  $\overline{WDOG} = 0x2$  in the RESBEHAVCTL register). Additionally, a BOR event should be configured to trigger an interrupt or issue a system reset ( $\overline{BOR} = 0x2$  in the RESBEHAVCTL register).

Depending on the system, there are a few potential workarounds:

- 1. Program the EEPROM only when the device is guaranteed to not have power removed and when a brown-out reset and an external reset will not occur. There are no restrictions on EEPROM reads.
- Use the Flash memory with application software to store data instead of the EEPROM controller.
- 3. Limit the number of lifetime EEPROM writes to 7 writes per word.
- 4. Use an external EEPROM.



MEM#04 Device may Become Non-functional if an EEPROM Write or Erase is Interrupted

Revision(s) Affected: B0 and 6.

**Description:** The device may not function if power is removed or if an external reset (RST) or a

brown-out reset (BOR) occurs during an EEPROM write or erase operation. When the WORKING bit of the EEDONE register is set, an EEPROM program or erase operation

is occurring. A reset will not recover the device.

If these events do not apply to your system, then normal EEPROM operation is

expected.

**Workaround(s):** Depending on the system, there are a few potential workarounds to this issue:

 Program and erase the EEPROM only when the device is guaranteed to not have power removed and when a brown-out reset and an external reset will not occur.

There are no restrictions on EEPROM reads.

Use the Flash memory with application software to store data instead of the EEPROM controller.

Limit the number of lifetime EEPROM writes to 7 writes per word.

Use an external EEPROM.



MEM#05 Device may Become Non-functional if Power is Interrupted During an Unlock of

the Microcontroller or During Non-volatile Register Commits

Revision(s) Affected: B0, 6, and 7.

**Description:** The device may not function if power is removed or if an external reset (RST) or a

brown-out reset (BOR) occurs while executing the debug port unlock sequence or while committing the contents of a non-volatile register. The debug port unlock sequence is described in the Recovering a "Locked" Microcontroller section in the JTAG chapter of the data sheet. Non-volatile registers are described in the Non-Volatile Register

Programming section in the Internal Memory chapter of the data sheet.





MEM#08 Writes and Erases to the EEPROM will not Work if the Three EEPROM Password

Registers are Used for Last EEPROM Block

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** Writes and erases to the EEPROM controller data and registers will not work if all three

EEPROM password registers are used to configure a password for the last EEPROM

block.

Workaround(s): The password for the last EEPROM block should not exceed 64-bits.



PWM#01 Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the

PWM is Enabled

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** A spurious PWM interrupt occurs immediately when the PWM is enabled under the

following conditions:

The PWM Load register contains a nonzero value and

• Either of the PWM Compare registers contains a value less than the value in the

PWM Load register and

PWM interrupts are enabled.



**PWM#02** Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is

Used

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** 

The bits in the PWM Time Base Sync (PWMSYNC) register are used to synchronize the counters in the PWM generators. The PWMDIV field in the PWM Clock Configuration (PWMCC) register is used to specify a fractional version of the system clock to use for the counters. If the PWMSYNC bits are set when the PWMDIV field is configured to

anything other than 0x0, the counters may not be synchronized.



QEI#01 When Using the Index Pulse to Reset the Counter, a Specific Initial Condition in

the QEI Module Causes the Direction for the First Count to be Misread

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** When using the index pulse to reset the counter with the following configuration in the

QEI Control (QEICTL) register:

SIGMODE is 0 indicating quadrature mode

CAPMODE is 1 indicating both PhA and PhB edges are counted

and the following initial conditions:

· Both PhA and PhB are 0

The next quadrature state is in the counterclockwise direction

the QEI interprets the state change as an update in the clockwise direction, which results

in a position mismatch of 2.



SSI#06 SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave

Mode

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The SSI receive FIFO time-out interrupt may assert sooner than 32 system clock periods

in slave mode if the CPSDVSR field in the SSI Clock Prescale (SSICPSR) register is set

to a value greater than 0x2. Master mode is not affected by this behavior.

Workaround(s): In some cases, software can use the SCR field in the SSI Control 0 (SSICR0) register in

combination with a CPSDVSR field value of 0x2 to attain the same SSI clock frequency. For example, if the desired serial clock rate is SysClk/48, then CPSDVSR = 0x2 and SCR = 0x17 can be used instead of CPSDVSR = 0x18 and SCR = 0x1 to achieve the same clock rate, using the equation SSInCLK = SysClk / (CPSDVSR \* (1 + SCR)). If there is not a value of SCR that can be used with CPSDVSR = 0x2 to attain the required

serial clock rate, then the receive FIFO time-out feature cannot be used.



SYSCTL#01 With a Specific Clock Configuration, Device may not Wake From Deep-Sleep Mode

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** With the following specific clock configuration, the device fails to wake from Deep-sleep

mode approximately 1 out of 1500 times. The configuration that may cause the issue is

as follows:

The PLL is using MOSC as the clock source, AND

The PLL is the system clock source before going in to Deep-sleep mode, AND

The Low-Frequency Internal Oscillator (LFIOSC) is the clock source during Deep-

sleep

Workaround(s): Either:

Use the PIOSC as the clock source for the PLL, OR

· Manually disable the PLL before entering Deep-sleep mode, OR

Use the PIOSC as the clock source during Deep-sleep





SYSCTL#03 The MOSC Verification Circuit Does not Detect a Loss of Clock After the Clock has

been Successfully Operating

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** If the MOSC clock source has been powered up and operating correctly and is

subsequently removed or flatlines, the MOSC verification circuit does not indicate an

error condition.

Workaround(s): Use Watchdog module 1, which runs off of PIOSC, to reset the system if the MOSC fails.



# SYSCTL#04 Device May not Wake Correctly From Sleep Mode Under Certain Circumstances

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** With a certain configuration, the device may not wake correctly from Sleep mode

because invalid data may be fetched from the prefetch buffer. The configuration that

causes this issue is as follows:

The system clock must be at least 40 MHz

Interrupts must be disabled

Workaround(s): Use following code instead of the ROM-based function ROM\_SysCtlSleep() to put the

device into Sleep mode:

```
__asm int
CPUwfi_safe(void) {
//
// Wait for the next interrupt.
//
wfi;
mov r0,#0 // force bx lr to not start until after clocks back on bx lr
}
```



SYSCTL#06 Resets Fail While in Deep-Sleep When Using Certain Clock Configurations

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** If a system reset occurs while in Deep-sleep mode when the MOSC is configured as the

clock source for both Run mode and Deep-sleep mode and the PIOSC is configured to power down in Deep-sleep, the MOSC is immediately disabled. The system cannot be clocked because the PIOSC is configured to be off. A power-on reset (POR) is required

to get the system out of this state.

Workaround(s): Use the PIOSC during Deep-sleep or use a system clock other than the MOSC.



SYSCTL#07 Deep-Sleep Clock Frequency Incorrect if a Watchdog Reset Occurs Upon Entry

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** If a watchdog reset occurs within 10 run-time clock cycles of entering Deep-sleep mode,

the clocking configuration for Deep-sleep may be overlooked. If this occurs, the first time the device enters Deep-sleep after the reset, the Run mode parameters used for the

system clock frequency are used instead.

The originally configured Deep-sleep clock configuration is reapplied after this first time

entering Deep-sleep.

Workaround(s): If the Run mode clock frequency does not have a significant impact to the user

application, no additional steps are necessary. If the Run mode clock frequency is undesirable for Deep-sleep mode, the watchdog module should be powered down in Run mode before entering Deep-sleep to ensure that a watchdog event does not occur

during the entry into Deep-sleep.



SYSCTL#11 Longer Reset Pulse Needed if Device is in Deep-Sleep Mode With the LFIOSC as

the Clock Source

Revision(s) Affected: A1, A3, B0, 6, and 7.

If the device is in Deep-Sleep mode with the LFIOSC as the clock source, the specified **Description:** 

reset pulse is not sufficient to reset the part in all cases.

Workaround(s): Ensure that the reset pulse is at least 30 ms if the part may be in Deep-Sleep mode with

the LFIOSC as the clock source.

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SYSCTL#14 Power Consumption is Higher When MOSC is Used in Single-Ended Mode

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The MOSC internal oscillator continues to run, even when a single-ended clock source is

attached to OSC0. This issue does not affect proper operation but does result in

additional power consumption of up to 3.5 mA.



# SYSCTL#16 On-Chip LDO may not Start Properly During Power Up

Revision(s) Affected:

A1, A3, B0, 6, and 7.

**Description:** 

In very rare cases, a non-monotonic voltage rise of VDDA between the minimum and maximum Power-On Reset Threshold ( $V_{POR}$ ) voltage range, 2.0 V and 2.6 V, can cause the on-chip LDO to not start up. Because the LDO controls the core voltage (VDDC), the device cannot start up correctly in this situation. If the LDO fails to start, power cycle the device until a successful power up occurs. A software or hardware reset cannot restart the LDO.

Workaround(s):

A monotonic voltage rise of VDDA prevents this issue from occurring; however, a perfect monotonic ramp is difficult to achieve, particularly during LDO inrush. The risk of encountering this issue can be minimized by performing one of the following:

- If the VDD and VDDA pins are connected directly to the same power source, at every possible point A and point B along the VDDA waveform between 2.0 V and 2.6 V, point B must never fall below point A after 15 µs, as shown in Figure 3.
- Use a separate power supply for VDDA to reduce noise and isolate it from the effects of LDO inrush. At every possible point A and point B along the VDDA waveform between 2.0 V and 2.6 V, point B must never fall below point A after 15 µs, as shown in Figure 3. The separate power supply will make it easier to avoid this condition.

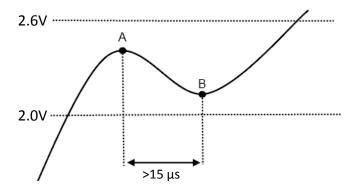


Figure 3. VDDA Waveform to Avoid Between V<sub>POR</sub> min and V<sub>POR</sub> max



SYSCTL#17 DSDIVORIDE Value of 0x1 Does not Divide Deep-Sleep Clock by 2

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** A value of 0x1 for the DSDIVORIDE bit field in the Deep Sleep Clock Configuration

(DSLPCLKCFG) register does not provide divide by two capability for the Deep-Sleep clock. The Run-mode clock divider will be used instead. All other DSDIVORIDE values

work as expected when entering Deep-Sleep.

Workaround(s): Software must program the SYSDIV bit field of the Run-Mode Clock Configuration (RCC)

register to the desired divider before entering Deep-Sleep if Deep-Sleep clock divide by 2 was intended for use. Note that when configuring the SYSDIV bit field, this will affect the Run-mode clock divider. Do not configure the clock divider such that the system clock speed is faster than the maximum clock frequency of 80 MHz before entering

Deep-Sleep.



UART#01 When UART SIR Mode is Enabled, μDMA Burst Transfer Does not Occur

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** If the IrDA Serial Infrared (SIR) mode is enabled in the UART peripheral and the  $\mu$ DMA

is mapped to either UARTn RX or UARTn TX and is configured to do a burst transfer,

the burst data transfer does not occur.

Workaround(s): Clear the SET bit in the DMA Channel Useburst Set (DMAUSEBURSTSET) register to

have the µDMA channel mapped to the UART to respond to single or burst requests to

ensure that the data transfer occurs.



USB Host Controller may not be Used to Communicate With a Low-Speed Device

When Connected Through a hub

**Revision(s) Affected:** A1, A3, B0, 6, and 7.

**Description:** Occasionally when the USB controller is operating as a Host and a low-speed packet is

sent to a Device when connected through a hub, the subsequent Start-of-Frame will be corrupted. After a period of time, this corruption causes the USB controller to lose

synchronization with the hub, resulting in data corruption.



USB Controller Sends EOP at end of Device Remote Wake-Up

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** When the USB controller is operating as a Device and is suspended by the Host, and

the USB controller issues a remote wake-up, an end of packet (EOP) is sent to the Host at the end of the Device's remote wake-up signal. Although this EOP is not expected, issues related to remote wake-up have not been observed. This does not affect USB

certification.



**WDT#01** Watchdog Timer 1 Module Cannot be Used Without Enabling Other Peripherals

**First** 

Revision(s) Affected: A1, A3, B0, 6, and 7.

The Watchdog Timer 1 module is not fully enabled by setting the WDT1 bit in the Run Mode Clock Gating Control Register 0 (RCGC0) register and, therefore, the module **Description:** 

cannot be used unless a different peripheral is enabled first.

Workaround(s): Enable at least one of the following peripherals before enabling the Watchdog Timer 1

module—UART, SSI, or ADC—by setting the respective bit(s) in the RCGUART,

RCGCSSI, or RCGCADC registers.



WDT#02 Watchdog Clear Mechanism Described in the Data Sheet Does not Work for the

Watchdog Timer 1 Module

**Revision(s) Affected:** A1, A3, B0, 6, and 7.

**Description:** Periodically reloading the count value into the Watchdog Timer Load (WDTLOAD)

register of the Watchdog Timer 1 module will not restart the count, as specified in the

data sheet.

Workaround(s): Disable the Watchdog Timer 1 module by setting the appropriate bit in the Watchdog

Timer Software Reset (SRWD) register before reprogramming the counter. Alternatively, clear the watchdog interrupt status periodically outside of the interrupt handler by writing

any value to the Watchdog Interrupt Clear (WDTICR) register.



WDT#03 Watchdog Timer 1 Module Asserts Reset Signal Even if not Programmed to Reset

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** Even if the reset signal is not enabled (the RESEN bit of the Watchdog Control

(WDTCTL) register is clear), the Watchdog Timer 1 module will assert a reset signal to

the system when the time-out value is reached for a second time.

Workaround(s): Clear the Watchdog Timer 1 interrupt once the time-out value is reached for the first time

by writing any value to the Watchdog Interrupt Clear (WDTICR) register.





WDT#05 WDTLOAD Yields an Incorrect Value When Read Back

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** If the Watchdog Timer 1 module is enabled and configured to run off the PIOSC, writes

to the Watchdog Load (WDTLOAD) register yield an incorrect value when read back.



WDT#06 WDTMIS Register Does not Indicate an NMI Interrupt From WDT0

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The WDTMIS bit of the Watchdog Masked Interrupt Status (WDTMIS) register does not

get set if a watchdog time-out non-maskable interrupt (NMI) interrupt from Watchdog Timer Module 0 has been signaled to the interrupt controller. This does not impact operation of the NMI interrupt. The NMI interrupt is still sent to the interrupt controller

when a WDT timeout occurs.



WDT#07 The Watchdog Load (WDTLOAD) Register Cannot be Changed When Using a

Debugger While the STALL bit is set

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description:** The Watchdog Load (WDTLOAD) register cannot be changed when using a debugger

with the STALL bit in the Watchdog Test (WDTTEST) register set.

Workaround(s): Avoid changing the Watchdog Load (WDTLOAD) register with the debugger connected

when the STALL bit is set.



WDT#08 Reading the WDTVALUE Register may Return Incorrect Values When Using

Watchdog Timer 1

Revision(s) Affected: A1, A3, B0, 6, and 7.

**Description** Incorrect values may be read from the Watchdog Value (WDTVALUE) register at the

Watchdog Timer 1 base address when using Watchdog Timer 1.



www.ti.com Revision History

# **Revision History**

This silicon errata revision history highlight the technical changes made to this document.

SEE	ADDITIONS/MODIFICATIONS/DELETIONS
Revision C (Febru	ary 2014) Changes Below:
Section 4 Known Design Exceptions to Functional Specifications	Added the following advisories:  ADC#11: The DITHER bit in the ADC Control (ADCCTL) Register Does not Function  ADC#16: Phase Offset does not Delay as Expected if Sample Sequencers are not Triggered at the Same Time  SSI#06: SSI Receive FIFO Time-out Interrupt may Assert Sooner than Expected in Slave Mode  SYSCTL#16: On-Chip LDO may not Start Properly During Power Up  SYSCTL#17: DSDIVORIDE Value of 0x1 Does Not Divide Deep-Sleep Clock by 2
Revision B (Octob	er 2013) Changes Below:
Section 4 Known Design Exceptions to Functional Specifications	Corrected GPIO#07: Only summary interrupt mode affected, not per-pin interrupt mode
Revision A (Octob	er 2013) Changes Below:
Section 4 Known Design Exceptions to Functional Specifications	Added the following advisories:  • GPIO#08: Certain GPIOs Have Limited Pin Configurations  • MEM#05: Device may Become Non-functional if Power is Interrupted During an Unlock of the Microcontroller or During Non-volatile Register Commits  • PWM#01: Under Certain Circumstances, the PWM Load Interrupt is Triggered as Soon as the PWM is Enabled  • PWM#02: Setting the PWMSYNC Bits May Not Synchronize the PWM Counters if PWMDIV is Used  • SYSCTL#14: Power Consumption is Higher When MOSC is Used in Single-Ended Mode  Clarified WDT#06: WDTMIS Register Does not Indicate an NMI Interrupt From WDT0  • Clarified that this does not impact operation of the NMI Interrupt.
•	Revision 7, September 2013) Changes Below:
Section 4 Known Design Exceptions to Functional Specifications	Added 7 in Silicon Revision Affected fields, where applicable.  Added the following advisories:  • ADC#13: A Glitch can Occur on pin PE3 when Using any ADC Analog Input Channel to Sample  • ADC#14: The First two ADC Samples may be Incorrect  • DMA#02: μDMA Data may be Corrupted if Transferred or Received While Entering or Exiting Deep-Sleep Mode  • ELEC#02: VBAT Supply pin may be Damaged if the pin Voltage Ramps Faster than 0.7 V/μs  • GPTM#09: General-Purpose Timers do not Synchronize when Configured for RTC or Edge Count Mode  • GPTM#15: Counter Does not Immediately Reset to 0 when MATCH is Reached in Edge Count Up Mode  • HIB#14: External Wake Interrupt may be Lost when Returning from Hibernation  • MEM#03: EEPROM Data may be Corrupted if an EEPROM Write or Erase is Interrupted  • MEM#04: Device may Become Non-functional if an EEPROM Write or Erase is Interrupted  • WDT#08: Reading the WDTVALUE Register may Return Incorrect Values when Using Watchdog Timer 1  Clarified GPTM#10: Writes to Some General-purpose Timer Registers Cause the Counter to Increment and Decrement in Some Cases

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

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